

Crystal chemistry, X-ray diffraction reference patterns, and bandgap studies for $(\text{Ba}_x\text{Sr}_{1-x})_2\text{CoWO}_6$ ($x = 0.1, 0.2, 0.3, 0.5, 0.7, \text{ and } 0.9$) – CORRIGENDUM

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In Wong-Ng *et al.* (2020), the last sentence of the first paragraph on page 198 was incorrect.

The sentence should read “Additionally, the reference X-ray diffraction (XRD) patterns for $(\text{Ba}_x\text{Sr}_{1-x})_2\text{CoWO}_6$ ($x = 0.2$ and 0.7) are measured to make them available as references through submission to the Powder Diffraction File as PDF Numbers 00-66-0546, 00-66-0547, 00-66-0548, 00-66-0549, 00-66-0550 and 00-69-0487 (Gates-Rector and Blanton, 2019)”.

Additionally, the reference (PDF, 2019) should be:

Gates-Rector, S. D. and Blanton, T. N., (2019). “The Powder Diffraction File: A Quality Materials Characterization Database,” *Powder Diffr.* **34**, 352–360.

Wong-Ng, W., Liu, G. Y., Shi, D. D., Yang, Y. Q., Derbeshi, R., Windover, D., and Kaduk, J. A. (2020). “Crystal chemistry, X-ray diffraction reference patterns, and bandgap studies for $(\text{Ba}_x\text{Sr}_{1-x})_2\text{CoWO}_6$ ($x = 0.1, 0.2, 0.3, 0.5, 0.7, \text{ and } 0.9$),” *Powder Diffr.* **35**, 197–205. doi:10.1017/S0885715620000342.